

**Notice of References Cited**

Application/Control No.

10/015,350

Applicant(s)/Patent Under  
Reexamination  
GONZALEZ ET AL.

Examiner

Stephen E. Jones

Art Unit

2817

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,194,765	03-1993	Dunlop et al.	307/443
	C	US-5,459,440	10-1995	Claridge et al.	333/17.3
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hayt et al., Engineering Circuit Analysis, 1978, McGraw-Hill Book Company, 3rd Edition, page 68.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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